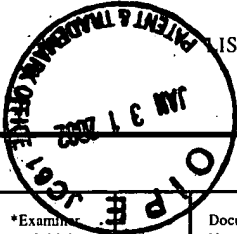


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U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
EO	AA 5,439,833	08/1995	Herbert, et al.	437	31	
	AB					
	AC					
	AD					
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	AG					
	AH					
	AI					
	AJ					
	AK					

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Subclass	Translation	
					Yes	No
AL 401276761-A	11/1989	Japan - Nonaka				

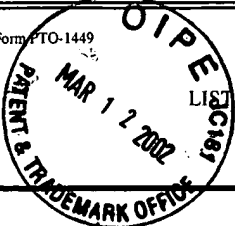
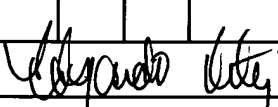
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

EO	AM	1	Ku et al. "The application of ion-beam mixing, coped silicide, a rapid thermal processing self-aligned silicide technology" VSLI Technology, Systems and Applications, May 17-19, 1989, Pages 337-341
EO	AN	2	Lange, H.; "Physical Properties of Semiconducting Transition Metal Silicides and their Prospects in Si-Based Device Applications"; IEEE 1998; Pages 247-250.
EO	AO	3	Mogami et al.; "Low-Resistance Self-Aligned Ti-Silicide Technology for Sub-Quarter Micron CMOS Devices"; IEEE 1996; Pages 932-939.

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4/3/02

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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
EO	AA	4,354,309	10/1982	Gardiner et al.			
EO	AB	4,559,091	12/1985	Allen et al.	148	174	
EO	AC	4,886,765	12/1989	Chen et al.	437	200	
EO	AD	5,192,708	03/1993	Beyer et al.	437	90	
EO	AE	5,393,676	02/1995	Anjum et al.	437	24	
EO	AF	5,712,181	01/1998	Byun et al.	437	46	
EO	AG	5,798,296	08/1998	Fazan et al.	438	592	
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							Yes No
EO		JP 02265248 A	04/1989	Japan - Kuriyama, Hiroko			
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	AM						
	AN						
	AO						
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	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No

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	AN		
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